

**G2402****N-CHANNEL ENHANCEMENT MODE POWER MOSFET**

BVDSS	20V
RDS(ON)	250mΩ
ID	3.2A

**Description**

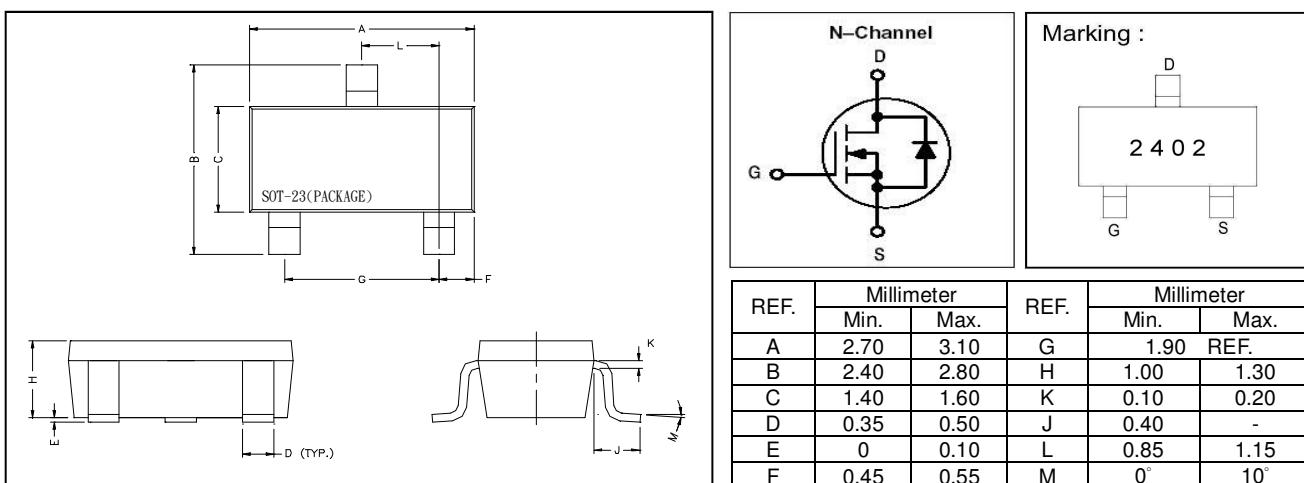
The G2402 provides the designer with the best combination of fast switching, low on-resistance and cost-effectiveness.

**Features**

- Ultra Low On-Resistance
- Fast Switching

**Applications**

- Power Management in Notebook Computer
- Portable Equipment
- Battery Powered System.

**Package Dimensions****Absolute Maximum Ratings**

Parameter	Symbol	Ratings	Unit
Drain-Source Voltage	V <sub>DS</sub>	20	V
Gate-Source Voltage	V <sub>GS</sub>	±12	V
Continuous Drain Current <sup>3</sup> , V <sub>GS</sub> @4.5V	I <sub>D</sub> @TA =25°C	3.2	A
Continuous Drain Current <sup>3</sup> , V <sub>GS</sub> @4.5V	I <sub>D</sub> @TA =70°C	2.6	A
Pulsed Drain Current <sup>1,2</sup>	I <sub>DM</sub>	7.4	A
Power Dissipation	P <sub>D</sub> @TA =25°C	1.38	W
Linear Derating Factor		0.01	W/°C
Operating Junction and Storage Temperature Range	T <sub>j</sub> , T <sub>stg</sub>	-55 ~ +150	°C

**Thermal Data**

Parameter	Symbol	Ratings	Unit
Thermal Resistance Junction-ambient <sup>3</sup> Max.	R <sub>thj-a</sub>	90	°C/W

## Electrical Characteristics( $T_j = 25^\circ\text{C}$ Unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Drain-Source Breakdown Voltage	$\text{BV}_{\text{DSS}}$	20	-	-	V	$\text{V}_{\text{GS}}=0$ , $\text{I}_D=250\mu\text{A}$
Breakdown Voltage Temperature Coefficient	$\Delta \text{BV}_{\text{DSS}}/\Delta T_j$	-	0.1	-	V/ $^\circ\text{C}$	Reference to $25^\circ\text{C}$ , $\text{I}_D=1\text{mA}$
Gate Threshold Voltage	$\text{V}_{\text{GS}(\text{th})}$	0.7	-	1.2	V	$\text{V}_{\text{DS}} = \text{V}_{\text{GS}}$ , $\text{I}_D=250\mu\text{A}$
Forward Transconductance	$\text{g}_{\text{fs}}$	-	6	-	S	$\text{V}_{\text{DS}}=10\text{V}$ , $\text{I}_D=0.47\text{A}$
Gate-Source Leakage Current	$\text{I}_{\text{GSS}}$	-	-	$\pm 100$	nA	$\text{V}_{\text{GS}}= \pm 12\text{V}$
Drain-Source Leakage Current( $T_j=25^\circ\text{C}$ )	$\text{I}_{\text{DSS}}$	-	-	1.0	$\mu\text{A}$	$\text{V}_{\text{DS}}=20\text{V}$ , $\text{V}_{\text{GS}}=0$
Drain-Source Leakage Current( $T_j=70^\circ\text{C}$ )		-	-	10	$\mu\text{A}$	$\text{V}_{\text{DS}}=20\text{V}$ , $\text{V}_{\text{GS}}=0$
Static Drain-Source On-Resistance <sup>2</sup>	$\text{R}_{\text{DS}(\text{ON})}$	-	-	250	$\text{m}\Omega$	$\text{I}_D=0.93\text{A}$ , $\text{V}_{\text{GS}}=4.5\text{V}$
		-	-	350		$\text{I}_D=0.47\text{A}$ , $\text{V}_{\text{GS}}=2.7\text{V}$
Total Gate Charge <sup>2</sup>	$\text{Q}_{\text{g}}$	-	4.4	-		$\text{I}_D=3.6\text{A}$
Gate-Source Charge	$\text{Q}_{\text{gs}}$	-	0.6	-		$\text{V}_{\text{DS}}=10\text{V}$
Gate-Drain ("Miller") Change	$\text{Q}_{\text{gd}}$	-	1.9	-		$\text{V}_{\text{GS}}=4.5\text{V}$
Turn-on Delay Time <sup>2</sup>	$\text{T}_{\text{d(on)}}$	-	5.2	-		
Rise Time	$\text{T}_r$	-	37	-		
Turn-off Delay Time	$\text{T}_{\text{d(off)}}$	-	15	-		
Fall Time	$\text{T}_f$	-	5.7	-		
Input Capacitance	$\text{C}_{\text{iss}}$	-	145	-		
Output Capacitance	$\text{C}_{\text{oss}}$	-	100	-		
Reverse Transfer Capacitance	$\text{C}_{\text{rss}}$	-	50	-		

## Source-Drain Diode

Forward On Voltage <sup>2</sup>	$\text{V}_{\text{SD}}$	-	-	1.2	V	$\text{I}_S=1.6\text{A}$ , $\text{V}_{\text{GS}}=0$ $\text{T}_j=25^\circ\text{C}$
Continuous Source Current(Body Diode)	$\text{I}_S$	-	-	1	A	$\text{V}_D = \text{V}_G = 0\text{V}$ , $\text{V}_S = 1.2\text{V}$
Pulsed Source Current (Body Diode) <sup>1</sup>	$\text{I}_{\text{SM}}$	-	-	7.4	A	

Notes: 1. Pulse width limited by Max. junction temperature.

2. Pulse width  $\leq 300\text{us}$ , duty cycle  $\leq 2\%$ .

3. Surface mounted on 1 in<sup>2</sup> copper pad of FR4 board;  $270^\circ\text{C}/\text{w}$  when mounted on min. copper pad.

## Characteristics Curve

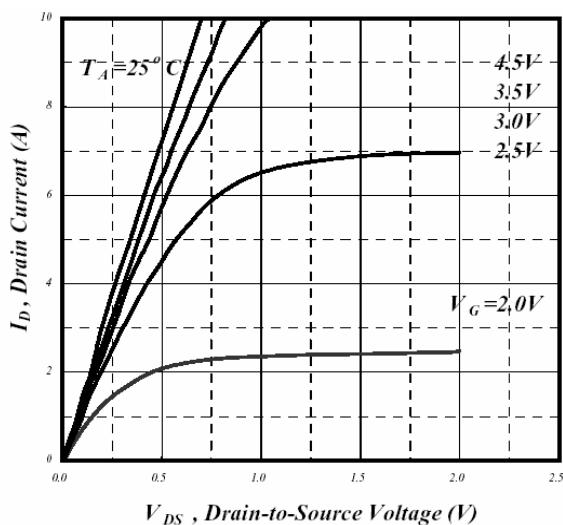


Fig 1. Typical Output Characteristics

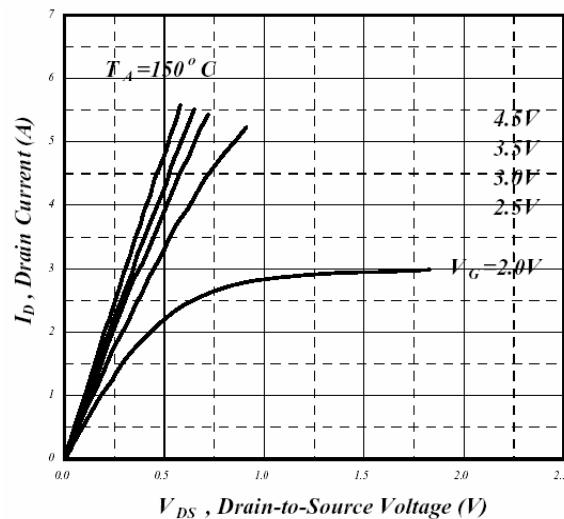


Fig 2. Typical Output Characteristics

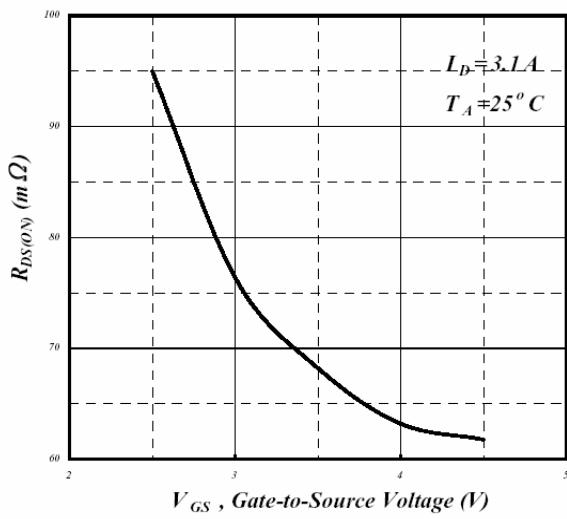


Fig 3. On-Resistance v.s. Gate Voltage

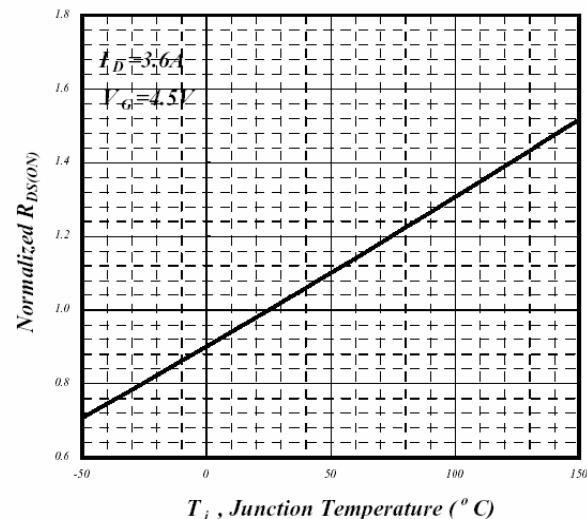


Fig 4. Normalized On-Resistance

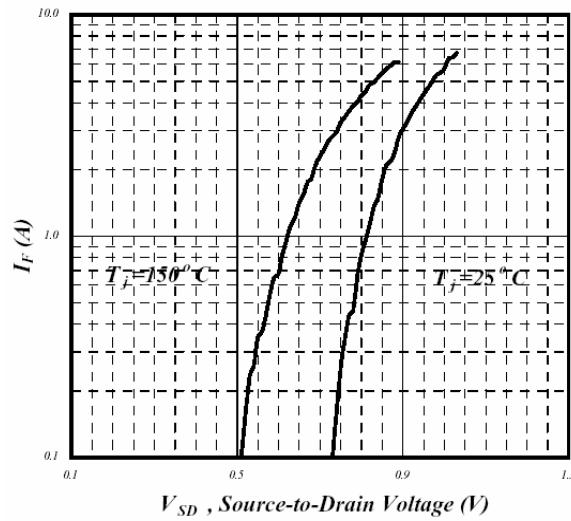


Fig 5. Forward Characteristic of Reverse Diode

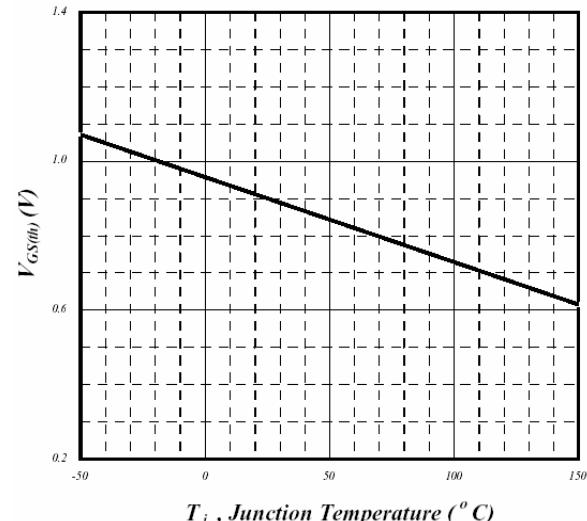


Fig 6. Gate Threshold Voltage v.s. Junction Temperature

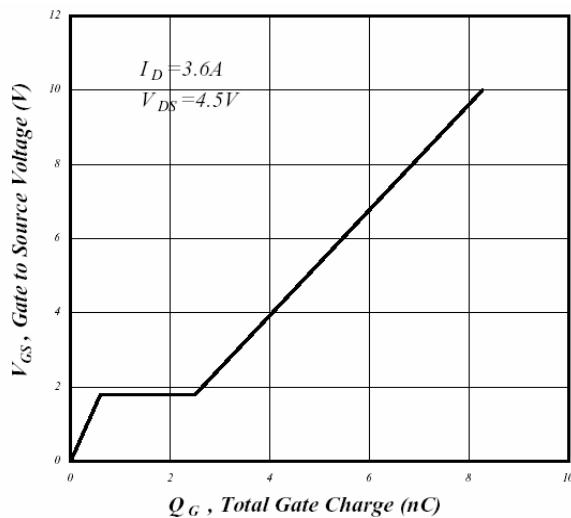


Fig 7. Gate Charge Characteristics

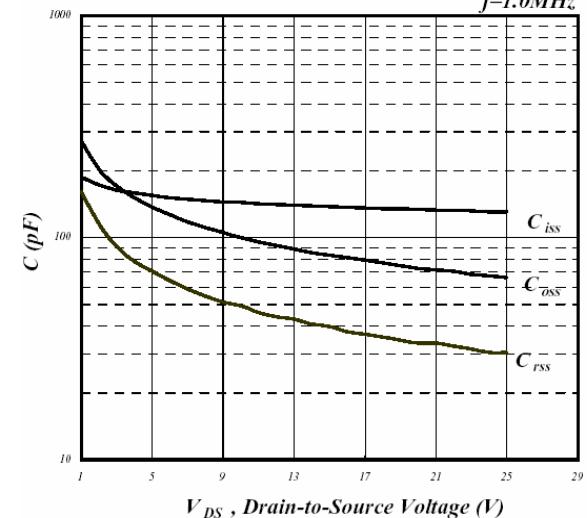
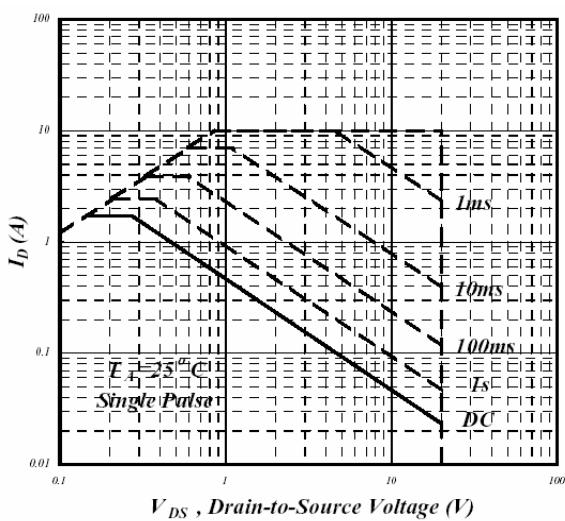
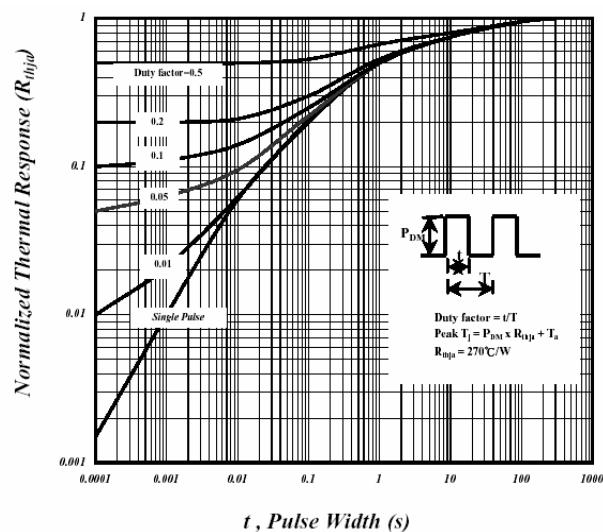


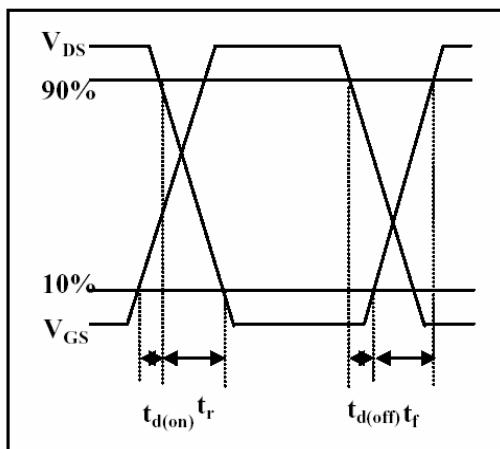
Fig 8. Typical Capacitance Characteristics



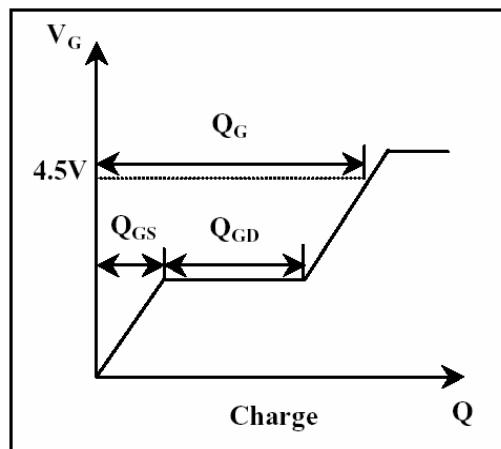
**Fig 9. Maximum Safe Operating Area**



**Fig 10. Effective Transient Thermal Impedance**



**Fig 11. Switching Time Waveform**



**Fig 12. Gate Charge Waveform**

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